N and P-Channel Enhancement Mode Power MOSFET

Description

The PT I \hat{I} \hat{F} Œuses advanced trench technology to provide excellent $R_{DS(ON)}$ and low gate charge . The SOP-8 package is universally preferred for all commercial industrial surface mount applications and suited for low voltage applications such as DC/DC converters.

General Features

N-Channel

 $V_{DS} = 30V, I_{D} = 1\dot{I}$ A

 $R_{DS(ON)}$ < 7.5m Ω @ VGS=10V

 $R_{DS(ON)}$ < 10m Ω @ VGS=5V

P-Channel

 $V_{DS} = -30V, I_{D} = -FGA$

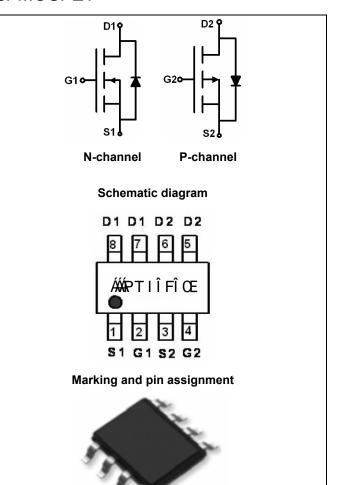
R_{DS(ON)} < GÍ { ô ÁO ÁX ÕÙMË LĚ XÁ

R_{DS(ON)} < FÎ { ô ÁO Á XÕÙM HE</sub>€X

- High power and current handing capability
- Lead free product is acquired
- Surface mount package

Application

- Battery protection
- Load switch
- Power management



SOP-8 top view

Package Marking and Ordering Information

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
PT I Î FÎ Œ	PT I Î FÎ Œ	SOP-8	Ø330mm	12mm	2500 units

Absolute Maximum Ratings (T_A=25 ℃unless otherwise noted)

Paramete	Symbol	N-Channel	P-Channel	Unit	
Drain-Source Voltage		V_{DS}	30	-30	V
Gate-Source Voltage		V_{GS}	±20	±20	V
Continuous Drain Current	T _A =25℃	- I _D	18	-12	А
Continuous Drain Current	T _A =70°C		13	-9	
Pulsed Drain Current (Note 1)		I _{DM}	50	-48	Α
Maximum Power Dissipation T _A =25℃		P _D	3	3	W
Operating Junction and Storage Temperature Range		T_{J} , T_{STG}	-55 To 150	-55 To 150	$^{\circ}$ C



Thermal Characteristic

Thermal Resistance, Junction-to-Ambient (Note2)	P	N-Ch	50	°C/W	
Thermal Nesistance, Junction-to-Ambient (Note2)	K _{⊕JA}	P-Ch	50	CIVV	

N-CH Electrical Characteristics (T_A=25 °C unless otherwise noted)

Parameter	Symbol	Condition	Min	Тур	Max	Unit	
Off Characteristics							
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V I _D =250µA	30	33	-	V	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =30V,V _{GS} =0V	-	-	1	μA	
Gate-Body Leakage Current	I _{GSS}	V _{GS} =±20V,V _{DS} =0V	-	-	±100	nA	
On Characteristics (Note 3)							
Gate Threshold Voltage	V _{GS(th)}	$V_{DS}=V_{GS}$, $I_{D}=250\mu A$	1	1.6	3	V	
Drain-Source On-State Resistance	В	V _{GS} =10V, I _D =9A	-	5.5	7.5	mΩ	
Dialii-Source Oil-State Resistance	R _{DS(ON)}	V _{GS} =5V, I _D =9A	-	7.5	10		
Forward Transconductance	g FS	V _{DS} =5V,I _D =18A	5	-	-	S	
Dynamic Characteristics (Note4)							
Input Capacitance	C _{lss}	V _{DS} =15V,V _{GS} =0V,	-	2100	-	PF	
Output Capacitance	Coss	V _{DS} =15V,V _{GS} =0V, F=1.0MHz	-	460	-	PF	
Reverse Transfer Capacitance	C _{rss}	r-1.0WInz	-	230	-	PF	
Switching Characteristics (Note 4)							
Turn-on Delay Time	t _{d(on)}		-	20	-	nS	
Turn-on Rise Time	t _r	V_{DD} =10 V , I_D =9 A	-	15	-	nS	
Turn-Off Delay Time	t _{d(off)}	V_{GS} =10 V , R_{GEN} =2.7 Ω	-	60	-	nS	
Turn-Off Fall Time	t _f		-	10	-	nS	
Total Gate Charge	Qg)/ 40\/ L 40A	-	41	-	nC	
Gate-Source Charge	Q _{gs}	$V_{DS}=10V,I_{D}=10A,$	-	14	-	nC	
Gate-Drain Charge	Q _{gd}	V _{GS} =10V	-	11	-	nC	
Drain-Source Diode Characteristics							
Diode Forward Voltage (Note 3)	V _{SD}	V _{GS} =0V,I _S =9A	-	-	1.2	V	
Diode Forward Current (Note 2)	Is		-	-	18	Α	

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P-CH Electrical Characteristics (T_A=25 °C unless otherwise noted)

Parameter	Symbol	Condition	Min	Тур	Max	Unit
Off Characteristics			•			
Drain-Source Breakdown Voltage	BV_{DSS}	V _{GS} =0V I _D =-250μA		-33	-	V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =-30V,V _{GS} =0V	-	-	-1	μA
Gate-Body Leakage Current	I _{GSS}	V _{GS} =±20V,V _{DS} =0V	-	-	±100	nA
On Characteristics (Note 3)						
Gate Threshold Voltage	$V_{GS(th)}$	V _{DS} =V _{GS} ,I _D =-250μA	-1	-1.5	-3	V
Daire Constitution		V _{GS} =-10V, I _D =-10A	-	11.5	15	mΩ
Drain-Source On-State Resistance	R _{DS(ON)}	V _{GS} =-4.5V, I _D =-7A	-	18	25	mΩ
Forward Transconductance	g FS	V _{DS} =-10V,I _D =-10A	20	-	-	S
Dynamic Characteristics (Note4)		1	u.	l	·	·
Input Capacitance	C _{lss}	15/1/ 01/	-	1750	-	PF
Output Capacitance	C _{oss}	V_{DS} =-15V, V_{GS} =0V,	-	215	-	PF
Reverse Transfer Capacitance	C_{rss}	F=1.0MHz	-	180	-	PF
Switching Characteristics (Note 4)		-	u.	l	·	·
Turn-on Delay Time	$t_{d(on)}$		-	9	-	nS
Turn-on Rise Time	t _r	V _{DD} =-15V, ID=-10A,	-	8	-	nS
Turn-Off Delay Time	$t_{\sf d(off)}$	V_{GS} =-10V, R_{GEN} =1 Ω	_	28	-	nS
Turn-Off Fall Time	t _f	1	_	10	-	nS
Total Gate Charge	Qg		-	24	-	nC
Gate-Source Charge	Q _{gs}	V _{DS} =-15V,I _D =-10A,V _{GS} =-10V	-	3.5	-	nC
Gate-Drain Charge	Q_{gd}	1	-	6	-	nC
Drain-Source Diode Characteristics	1		1	ı	ı	ı
Diode Forward Voltage (Note 3)	V _{SD}	V _{GS} =0V,I _S =-2A	-	-	-1.2	V

Notes:

- 1. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 2. Surface Mounted on FR4 Board, t ≤ 10 sec.
- 3. Pulse Test: Pulse Width \leq 300 μ s, Duty Cycle \leq 2%.
- 4. Guaranteed by design, not subject to production

N- Channel Typical Electrical and Thermal Characteristics (Curves)

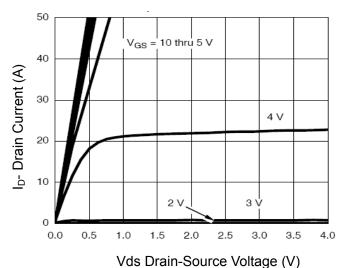
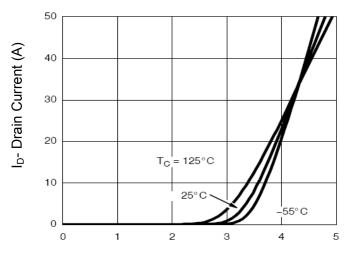


Figure 1 Output Characteristics



Vgs Gate-Source Voltage (V)

Figure 2 Transfer Characteristics

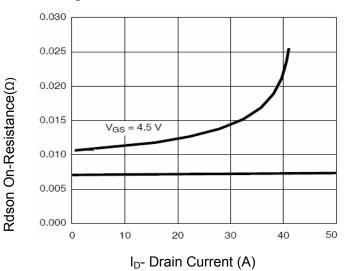


Figure 3 Rdson- Drain Current

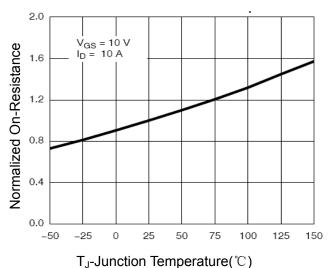


Figure 4 Rdson- Junction Temperature

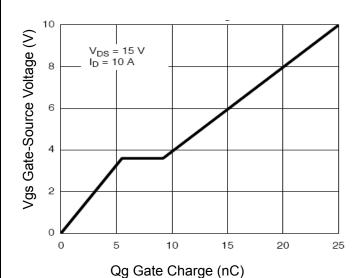


Figure 5 Gate Charge

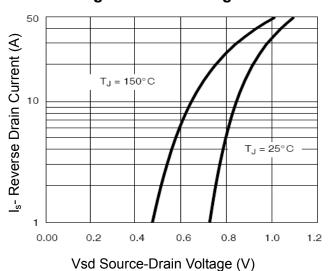


Figure 6 Source- Drain Diode Forward

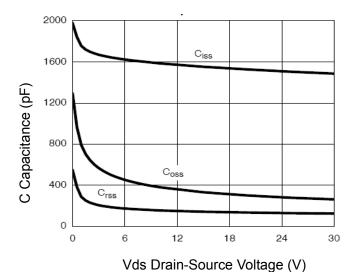


Figure 7 Capacitance vs Vds

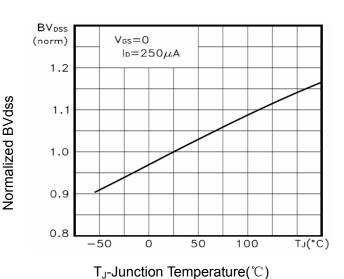
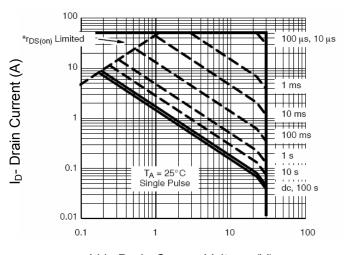


Figure 9 BV_{DSS} vs Junction Temperature



Vds Drain-Source Voltage (V)
Figure 8 Safe Operation Area

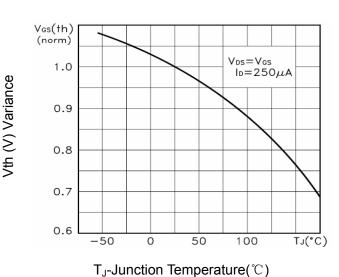


Figure 10 V_{GS(th)} vs Junction Temperature

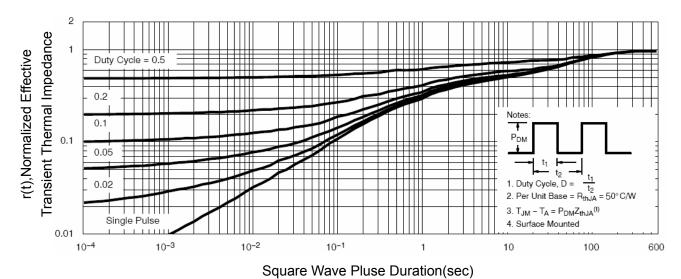


Figure 11 Normalized Maximum Transient Thermal Impedance

P-Channel Typical Electrical and Thermal Characteristics

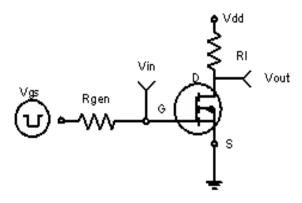


Figure 1:Switching Test Circuit

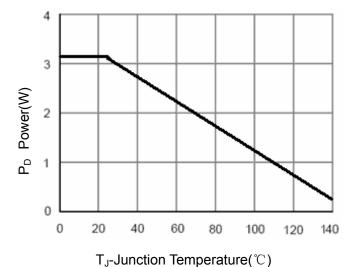


Figure 3 Power Dissipation

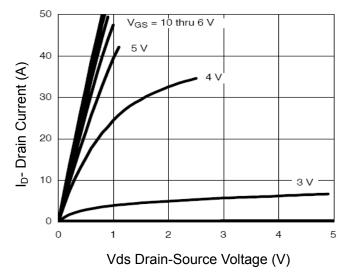


Figure 5 Output Characteristics

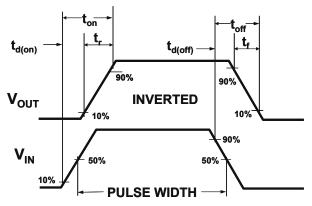


Figure 2:Switching Waveforms

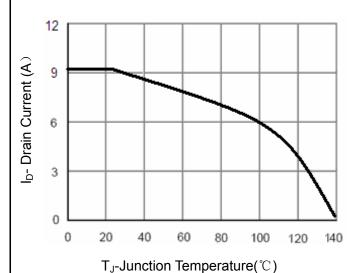


Figure 4 Drain Current

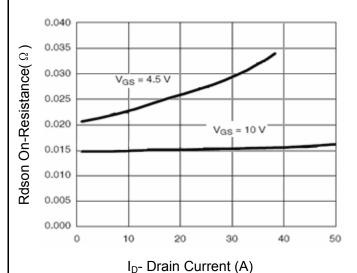


Figure 6 Drain-Source On-Resistance

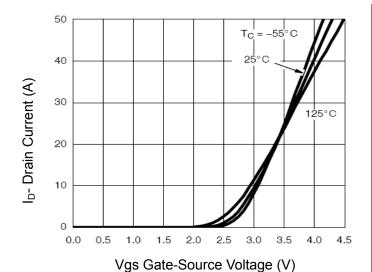
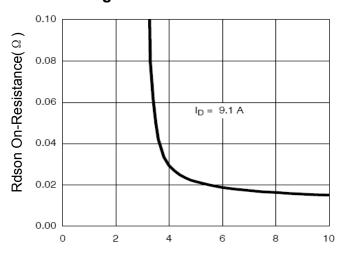


Figure 7 Transfer Characteristics



Vgs Gate-Source Voltage (V)

Figure 9 Rdson vs Vgs

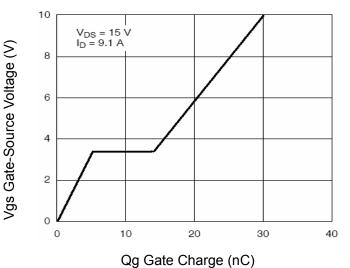


Figure 11 Gate Charge

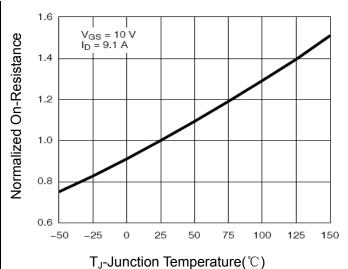
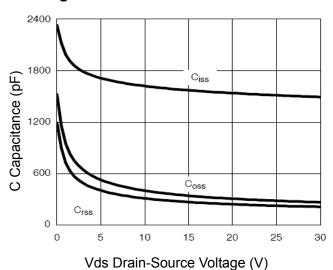


Figure 8 Drain-Source On-Resistance



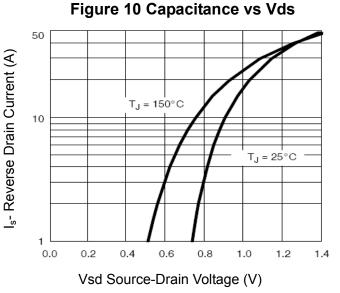
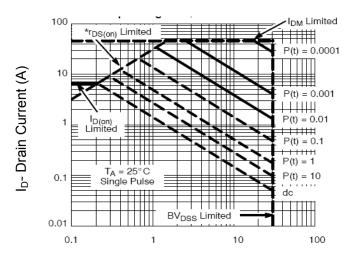


Figure 12 Source- Drain Diode Forward



Vds Drain-Source Voltage (V)

Figure 13 Safe Operation Area

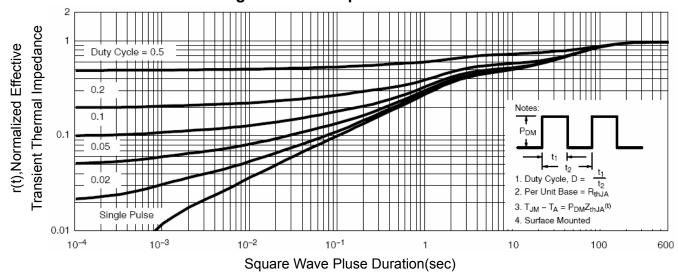
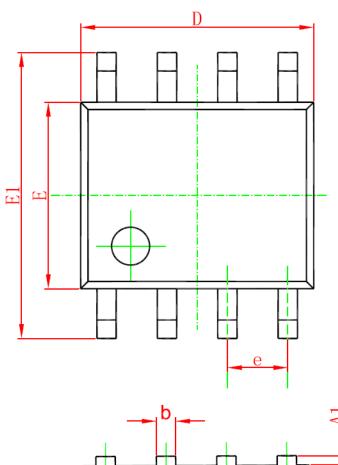
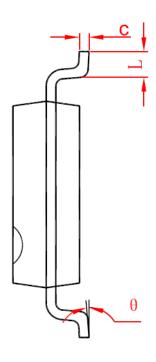
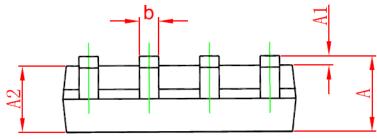


Figure 14 Normalized Maximum Transient Thermal Impedance

SOP-8 Package Information







C. mh a l	Dimensions In	n Millimeters	Dimensions In Inches		
Symbol	Min	Max	Min	Max	
Α	1. 350	1. 750	0. 053	0. 069	
A1	0. 100	0. 250	0.004	0. 010	
A2	1. 350	1. 550	0. 053	0. 061	
b	0. 330	0. 510	0. 013	0. 020	
С	0. 170	0. 250	0.006	0. 010	
D	4. 700	5. 100	0. 185	0. 200	
Е	3. 800	4. 000	0. 150	0. 157	
E1	5. 800	6. 200	0. 228	0. 244	
е	1. 270 (BSC)		0.050	(BSC)	
L	0. 400	1. 270	0. 016	0. 050	
θ	0°	8°	0°	8°	

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